

STP80NF06 - STB80NF06 STW80NF06

N-channel 60V - 0.0065Ω - 80A TO-220/D²PAK/TO-247 STripFET II™ Power MOSFET

Features

Туре	V _{DSS}	V _{DSS} R _{DS(on)}	
STB80NF06	60V	<0.008Ω	80A
STP80NF06	60V	<0.008Ω	80A
STW80NF06	60V	<0.008Ω	80A

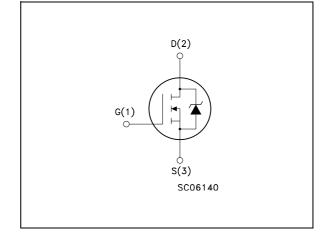
- 100% avalanche tested
- Low threshold drive

Description

This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

TO-220 TO-220 TO-247 TO-247 TO-247 D2PAK

Internal schematic diagram



Applications

Switching application

Order codes

Part number	Marking	Package	Packaging
STB80NF06T4	B80NF06	D ² PAK	Tape & reel
STP80NF06	P80NF06	TO-220	Tube
STW80NF06	W80NF06	TO-247	Tube

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1 Electrical ratings

Table 1.	Absoluto	maximum	ratinge
Table I.	Absolute	maximum	raungs

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (v _{gs} = 0)	60	V
V _{GS}	Gate- source voltage	±20	V
I _D ⁽¹⁾	Drain current (continuous) at $T_{C} = 25^{\circ}C$	80	Α
I _D	Drain current (continuous) at T _C = 100°C	80	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	320	Α
P _{TOT}	Total dissipation at $T_C = 25^{\circ}C$	300	W
	Derating factor	2	W/°C
E _{AS} ⁽³⁾	Single pulse avalanche energy	870	mJ
T _{stg}	Storage temperature	– 65 to 175	°C
Тj	Max. operating junction temperature	175	

1. Current limited by wire bonding

2. Pulse width limited by safe operating area

3. Starting T_j = 25°C, I_D = 40A, V_{DD} =40V

Table 2. Thermal data

R _{thj-case}	Thermal resistance junction-case Max	0.5	°C/W
R _{thj-a}	Thermal resistance junction-ambient Max	62.5	°C/W
TI	Maximum lead temperature for soldering purpose	300	°C



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source Breakdown voltage	I _D = 250 μA, V _{GS} = 0	60			V
I _{DSS}	Zero gate voltage Drain current (V _{GS} = 0)	V _{DS} = Max rating V _{DS} =Max rating, T _C =125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 20V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 40A		0.0065	0.008	Ω

Table 3. On/off states

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 2.5V _, I _D =18A		20		S
C _{iss}	Input capacitance			3850		pF
C _{oss}	Output capacitance	$V_{DS} = 25V$, f = 1 MHz, $V_{GS} = 0$		800		pF
C _{rss}	Reverse transfer capacitance			250		pF
Qg	Total gate charge	N/ 001/1 001		115	150	nC
Q _{gs}	Gate-source charge	V _{DD} = 80V, I _D = 80A, V _{GS} = 10V		24		nC
Q _{gd}	Gate-drain charge	VGS - 10 V		46		nC

1. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

Table 5. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	$V_{DD} = 27V, I_D = 40A$ R _G = 4.7 Ω V _{GS} = 10V (see Figure 13)		25 85		ns ns
t _{d(off)} t _f	Turn-off-delay time Fall time	$V_{DD} = 27V, I_D = 40A,$ $R_G = 4.7\Omega, V_{GS} = 10V$ (see Figure 13)		70 25		ns ns
t _{d(off)} t _f t _c	Off-voltage Rise Time Fall Time Cross-over Time	Vclamp =44V, I_D =80A R _G = 4.7 Ω , V _{GS} = 10V (see Figure 15)		85 75 110		ns ns ns

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I _{SD}	Source-drain current				80	А
$I_{SDM}^{(1)}$	Source-drain current (pulsed)				320	А
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 80A, V_{GS} = 0$			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$\begin{split} I_{SD} &= 80A, V_{DD} = 50V \\ di/dt &= 100A/\mu s, \\ T_j &= 150^\circ C \\ (see Figure 15) \end{split}$		80 250 6.4		ns nC A

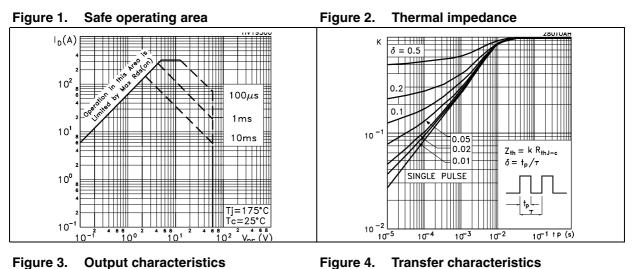
Table 6.Source drain diode

1. Pulse width limited by safe operating area.

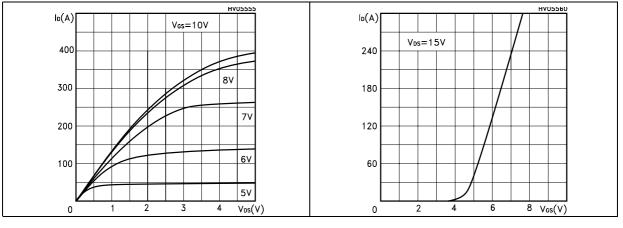
2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

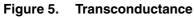


Electrical characteristics (curves) 2.1









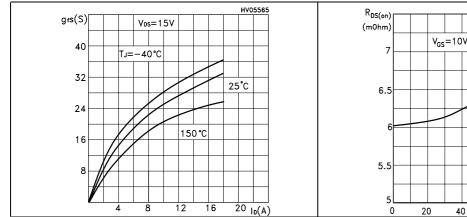
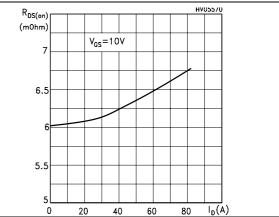


Figure 6. Static drain-source on resistance



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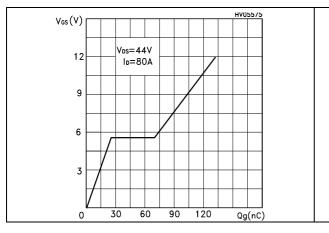
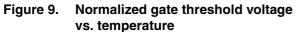


Figure 7. Gate charge vs. gate-source voltage Figure 8. Capacitance variations



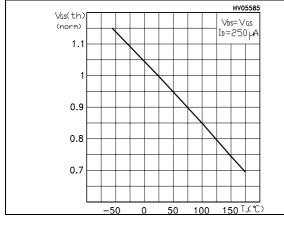


Figure 11. Source-drain diode forward characteristics

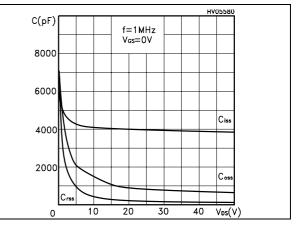


Figure 10. Normalized on resistance vs. temperature

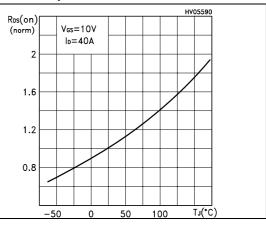
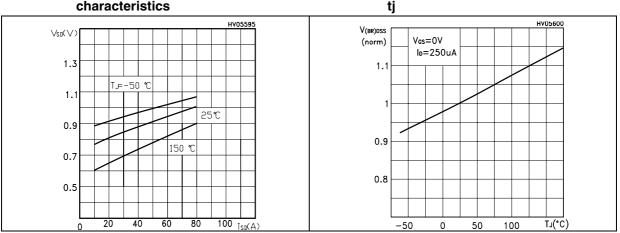
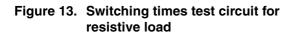


Figure 12. Normalized breakdown voltage vs.



3 Test circuit



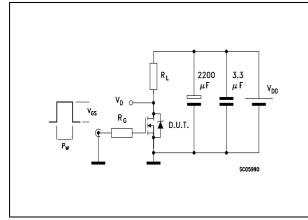
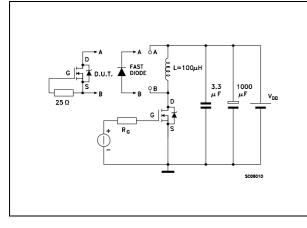
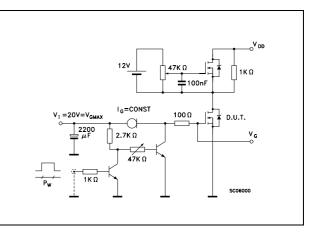
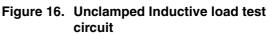


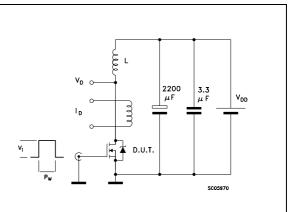
Figure 15. Test circuit for inductive load switching and diode recovery times





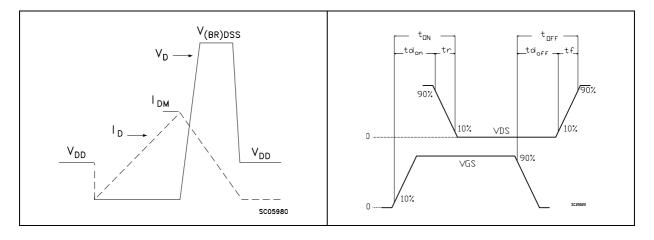


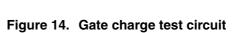




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Figure 18. Switching time waveform





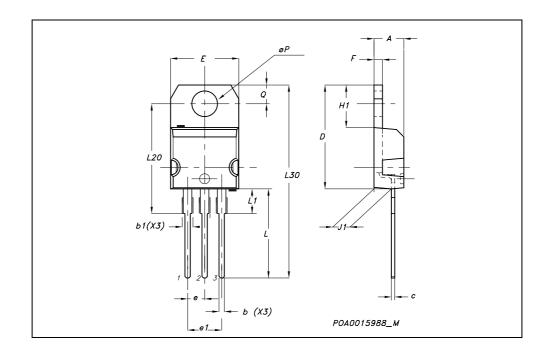
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at : *www.st.com*



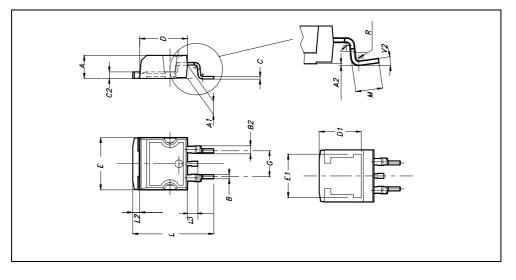
DIM.		mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.	
А	4.40		4.60	0.173		0.181	
b	0.61		0.88	0.024		0.034	
b1	1.15		1.70	0.045		0.066	
С	0.49		0.70	0.019		0.027	
D	15.25		15.75	0.60		0.620	
E	10		10.40	0.393		0.409	
е	2.40		2.70	0.094		0.106	
e1	4.95		5.15	0.194		0.202	
F	1.23		1.32	0.048		0.052	
H1	6.20		6.60	0.244		0.256	
J1	2.40		2.72	0.094		0.107	
L	13		14	0.511		0.551	
L1	3.50		3.93	0.137		0.154	
L20		16.40			0.645		
L30		28.90			1.137		
øР	3.75		3.85	0.147		0.151	
Q	2.65		2.95	0.104		0.116	





DW	mm.			inch		
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
В	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
С	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
М	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0º		4º	1		

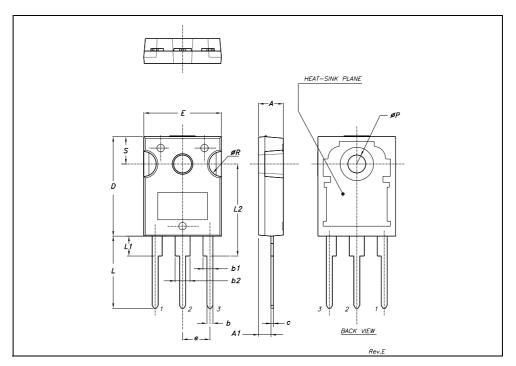






DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	2.0		2.40	0.079		0.094
b2	3.0		3.40	0.118		0.134
С	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
E	15.45		15.75	0.608		0.620
е		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øP	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	

TO-247 MECHANICAL DATA



5 Revision history

Table 7.	Revision	historv

Date	Revision	Changes
09-Sep-2004	1	Complete version
21-Jun-2005	2	The word "STripFET" in the description title on the web was been corrected
17-Aug-2006	3	The document has been reformatted
31-Jan-2007	4	Typo mistake on Table 1.
03-May-2007	5	R _{DS(on)} Max value has been changed



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